



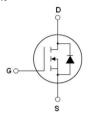
N-Channel Super Junction Power MOSFET II

General Description

The series of devices use advanced super junction technology and design to provide excellent R_{DS(ON)} with low gate charge. This super junction MOSFET fits the industry's AC-DC SMPS requirements for PFC, AC/DC power conversion, and industrial power applications.

Features

- ◆ New technology for high voltage device
- ◆ Low on-resistance and low conduction losses
- ◆ Small package
- ◆ Ultra Low Gate Charge cause lower driving requirements
- ◆ 100% Avalanche Tested
- ◆ ROHS compliant





Schematic diagram

TO-252

Application

- ◆ Power factor correction (PFC)
- Switched mode power supplies(SMPS)
- ◆ Uninterruptible Power Supply (UPS)

| V _{DS} @T _{jmax} | 650 | V |
|------------------------------------|-----|----|
| Rds(on) max | 540 | mΩ |
| ID | 8 | Α |

Package Marking And Ordering Information

| Device Package | | Marking | |
|----------------|--------|-----------|--|
| MJ60R540K | TO-252 | MJ60R540K | |

Table 1. Absolute Maximum Ratings (Tc=25℃)

| Parameter | Symbol | Value | Unit |
|--|-------------|-------|------|
| Drain-Source Voltage (Vss=0V) | VDS | 600 | V |
| Gate-Source Voltage (V _{DS} =0V) | Vgs | ±30 | V |
| Continuous Drain Current at Tc=25°C | ID (DC) | 8 | А |
| Continuous Drain Current at Tc=100°C | ID (DC) | 5.2 | A |
| Pulsed drain current (Note 1) | IDM (pluse) | 24 | А |
| Maximum Power Dissipation (Tc=25°C) | Po | 80 | W |
| Derate above 25°C | PD | 0.64 | W/°C |
| Single pulse avalanche energy (Note 2) | Eas | 185 | mJ |
| Avalanche current (Note 1) | lar | 4 | А |
| Repetitive Avalanche energy, tar limited by T _{jmax} (Note 1) | Ear | 0.4 | mJ |

| Parameter | Symbol | Value | Unit |
|--|----------------------|---------|------|
| Drain Source voltage slope, V _{DS} ≤480 V | dv/dt | 50 | V/ns |
| Reverse diode dv/dt, V _{DS} ≤480 V,I _{SD} <i<sub>D</i<sub> | dv/dt | 15 | V/ns |
| Operating Junction and Storage Temperature Range | T _J ,Tsтg | -55+150 | °C |





Table 2. Thermal Characteristic

| Parameter | Symbol | Value | Unit |
|---|--------|-------|------|
| Thermal Resistance, Junction-to-Case (Maximum) | RthJC | 1.56 | °C/W |
| Thermal Resistance, Junction-to-Ambient (Maximum) | RthJA | 62 | °C/W |

Table 3. Electrical Characteristics (T_A=25℃ unless otherwise noted)

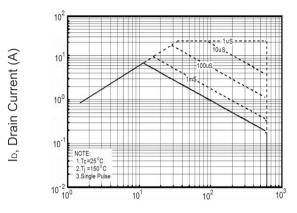
| Parameter | Symbol | Condition | Min | Тур | Max | Unit |
|--|---------------------|--|-----|------|------|------|
| On/off states | ' | | | | | |
| Drain-Source Breakdown Voltage | BVDSS | V _{GS} =0V I _D =250µA | 600 | - | - | V |
| Zero Gate Voltage Drain Current (Tc=25℃) | loss | V _{DS} =600V,V _{GS} =0V | - | - | 1 | μΑ |
| Zero Gate Voltage Drain Current (Tc=125°C) | loss | V _{DS} =600V,V _{GS} =0V | - | - | 100 | μΑ |
| Gate-Body Leakage Current | lgss | V _{GS} =±30V,V _{DS} =0V | - | - | ±100 | nA |
| Gate Threshold Voltage | V _{GS(th)} | V _{DS} =V _{GS} ,I _D =250µA | 2.5 | 3 | 3.5 | V |
| Drain-Source On-State Resistance | Rds(on) | V _{GS} =10V,I _D =4A | - | 480 | 540 | mΩ |
| Dynamic Characteristics | | | | | | |
| Forward Transconductance | G FS | V _{DS} =20V,I _D =4A | - | 5.5 | _ | S |
| Input Capacitance | Cies | | - | 680 | - | PF |
| Output Capacitance | Coss | V _{DS} =50V,V _{GS} =0V F=1.0MHz | - | 58 | - | PF |
| Reverse Transfer Capacitance | Crss | | - | 4 | - | PF |
| Total Gate Charge | Qg | | - | 14.5 | 22 | nC |
| Gate-Source Charge | Qgs | V _{DS} =480V,I _D =8A V _{GS} =10V | - | 2.8 | - | nC |
| Gate-Drain Charge | Qgd | | - | 5.5 | - | nC |
| Intrinsic gate resistance | Rg | f=1 MHz open drain | - | 2 | - | Ω |
| Switching times | | | | | | |
| Turn-on Delay Time | t _{d(on)} | | - | 5.5 | _ | nS |
| Turn-on Rise Time | tr | V _{DD} =380V,I _D =4A | - | 3.5 | - | nS |
| Turn-Off Delay Time | t _{d(off)} | R _G =12Ω,V _{GS} =10V | - | 55 | 75 | nS |
| Turn-Off Fall Time | tr | - | - | 6.5 | 10 | nS |
| Source- Drain Diode Characteristics | | | | | | |
| Source-drain current (Body Diode) | Isp | | - | - | 8 | А |
| Pulsed Source-drain current (Body Diode) | Isdm | - Tc=25°C | - | - | 23.4 | А |
| Forward On Voltage | Vsp | Tj=25°C,Isp=8A,Vgs=0V | - | 0.9 | 1.2 | V |
| Reverse Recovery Time | t _{rr} | | - | 220 | - | nS |
| Reverse Recovery Charge | Qrr | Tj=25°C,I⊧=8A di/dt=100A/µs | - | 2.2 | - | uC |
| Peak reverse recovery current | Irrm | | _ | 20 | _ | А |



Notes

- 1.Repetitive Rating: Pulse width limited by maximum junction temperature
- $2.T_j=25^{\circ}C,V_{DD}=50V,V_{G}=10V,R_{G}=25\Omega$

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS (curves)



V_{DS}, Drain-Source Voltage (V)

Figure 1 Safe operating area

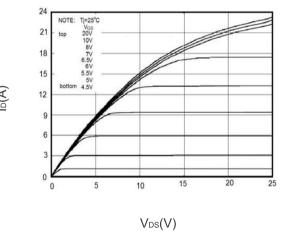
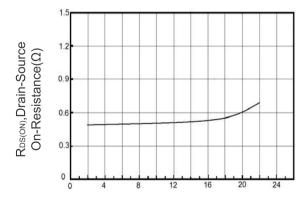
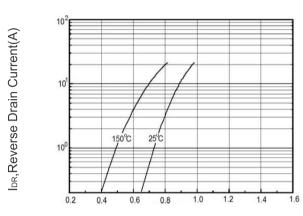


Figure 3 Output characteristics



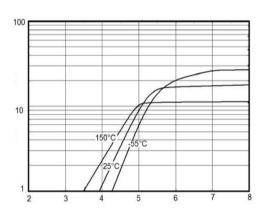
I_D, Drain Current (A)
Figure 5 Static drain-source

on resistance



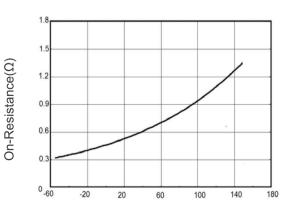
V_{SD},Source-Drain Voltage(V)

Figure 2 Source-Drain Diode Forward Voltage



V_{GS}, Gate-Source Voltage (V)

Figure 4 Transfer characteristics



T_J, Junction Temperature (°C)

Figure 6 Rds(ON) vs Junction Temperature

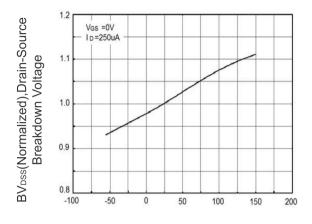
lb, Drain Current (A)

ADS(ON), Drain-Source

lo, Drain Current (A)

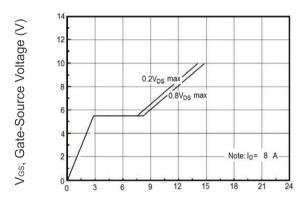
Capacitances(pF)





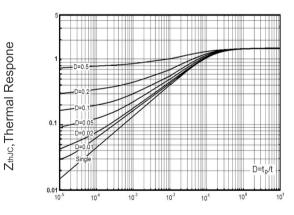
T_J, Junction Temperature (°C)

Figure 7 BVDSS vs Junction Temperature



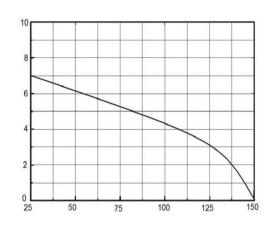
Q_G,Total Gate Charge(nC)

Figure 9 Gate charge waveforms



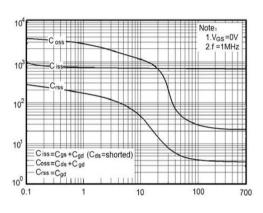
tp,Square Wave Pulse(S)

Figure 11 Transient Thermal Impedance



Tc, Case Temperature (°C)

Figure 8 Maximum I_D vs Junction Temperature



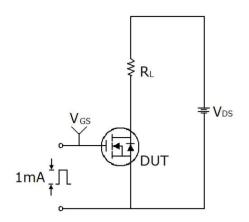
V_{DS}, Drain-Source Voltage (V)

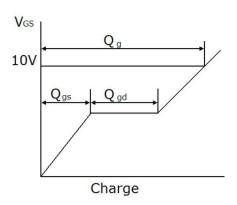
Figure 10 Capacitance



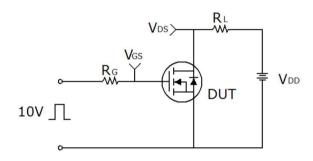


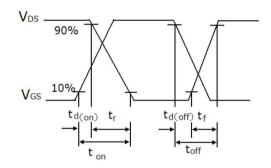
Test circuit



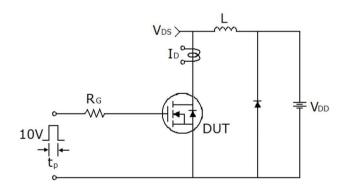


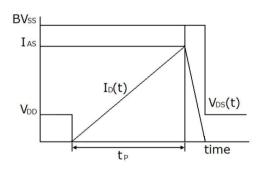
Gate charge test circuit & Waveform





Switch Time Test Circuit



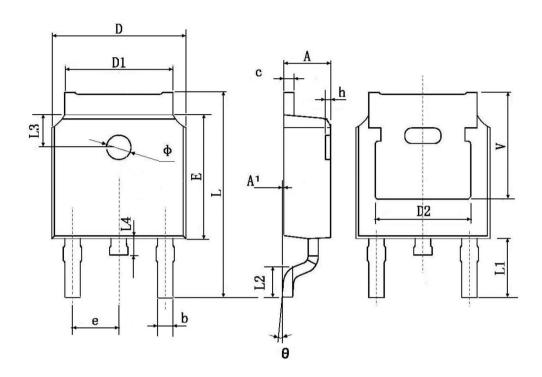


Unclamped Inductive Switching Test Circuit & Waveforms





TO-252 Package Information



| Symbol | Dimensions In Millimeters | | Dimensions In Inches | |
|--------|---------------------------|------------|----------------------|-------|
| Symbol | Min. | Max. | Min. | Max. |
| А | 2.200 | 2.400 | 0.087 | 0.094 |
| A1 | 0.000 | 0.127 | 0.000 | 0.005 |
| b | 0.660 | 0.860 | 0.026 | 0.034 |
| С | 0.460 | 0.580 | 0.018 | 0.023 |
| D | 6.500 | 6.700 | 0.256 | 0.264 |
| D1 | 5.100 | 5.460 | 0.201 | 0.215 |
| D2 | 4.830 | 4.830 TYP. | | TYP. |
| Е | 6.000 | 6.200 | 0.236 | 0.244 |
| е | 2.186 | 2.386 | 0.086 | 0.094 |
| L | 9.800 | 10.400 | 0.386 | 0.409 |
| L1 | 2.900 | 2.900 TYP. | | TYP. |
| L2 | 1.400 | 1.700 | 0.055 | 0.067 |
| L3 | 1.600 | 1.600 TYP. | | TYP. |
| L4 | 0.600 | 1.000 | 0.024 | 0.039 |
| Ф | 1.100 | 1.300 | 0.043 | 0.051 |
| θ | 0° | 8° | 0° | 8° |
| h | 0.000 | 0.300 | 0.000 | 0.012 |
| V | 5.350 TYP. | | 0.211 | TYP. |





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